

Data Sheet- EddyCus® TF map 2530SR-MT

P_T_2530_11



Highlights

- Contact-free imaging
- High resolution imaging (25 to 1,000,000 points)
- Integrity and defect imaging
- Mapping of encapsulated layers

Applications

- Semiconductors
- Photovoltaics
- Touch panel sensors
- Displays and lighting
- Batteries, capacitors, fuel cells
- De-icing and heating
- Smart-glass and LowE
- WLP, PCB
- Packaging materials
- Antistatic

Processes

- Deposition (PVD, evaporation, plating, CVD, ALD ...)
- Layer and material modification (implantation, doping, annealing)
- Layer removal (CMP, etching, scribing ...)

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Made and Engineered in Germany

Innovation Award by Free State of Saxony 2013 1st Place

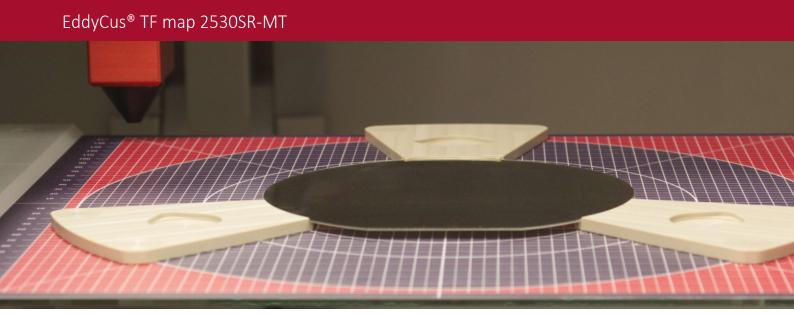


Materials

- Semiconductors (Si, SiC, GaAs ...)
- Metals

- Mesh and nanowire films
- ► Conductive inks, polymers (PEDOT)
- Other conductive films

- ► Graphene, CNT, graphite
- Conductive oxides and nitrides



Measurement technology	Non-contact eddy current sensor
Substrates	Wafer, glass, foils etc.
Max. scanning area	12 inch / 300 mm x 300 mm (larger on request)
Edge effect correction / exclusion	2 – 10 mm (depending on size, measurement range and requirements)
Max. sample thickness / sensor gap	1 / 2 / 5 / 10 / 25 mm (defined by the thickest sample)
Thickness measurement of metal films (e.g. copper) Accuracies depend on the selected setup and the type of metal. Accuracies of 1% can be achieved in good setups eg. for Cu and Al	Low 1 – 10 nm; < 3 % accuracy Standard 10 – 1,000 nm; < 3 % accuracy High 1 – 100 μm; < 3 % accuracy
Sheet resistance range	0.1 mOhm/sq – 100,000 Ohm/sq
Scanning pitch (X and Y)	1 / 2.5 / 5 / 10 / 25 mm (other on request)
Measurement points per time (square shape)	100 measurement points in 0.5 minutes 10,000 measurement points in 5 minutes 1,000,000 measurement points in 30 minutes
Scanning time	8 inch / 200 mm x 200 mm in 1.5 to 15 minutes (1 – 10 mm pitch) 12 inch / 300 mm x 300 mm in 2 to 15 minutes (2.5 – 25 mm pitch)
Device dimension (w /h /d) / weight	31.5 x 19.1 x 33.5 inch / 799 x 486 x 850 mm / 90 kg

Software and Handling - Sheet Resistance Analyzer 2.0

